



# Editorial

## JCISE Editorial Board—Year 2022

The *Journal of Computing and Information Science in Engineering* (JCISE) publishes articles related to scientific computing methods (e.g., modeling, simulation, representation, and algorithm) and computational tools (e.g., high-performance computing, virtual and augmented reality) that aim to improve engineering products and systems for their complete lifecycle (e.g., design, manufacturing, operation, maintenance, disposal, and recycling). The interest areas include computational geometry, computer-aided design and manufacturing, cyber-physical systems, human-machine interface, machine intelligence, machine learning, modeling and simulation, precision engineering, product lifecycle management, reverse engineering, and systems engineering.

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